Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/768,507	MAIER ET AL:
Examiner	Art Unit
John I Figueroa	1712

SEARCHED				
Class	Subclass	Date	Examiner	
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STIC (Chemical Structure Search)	8/14/2007	JJF
NDI (Non Batont Literature Searched		
NPL (Non-Patent Literature Searched on STIC and on internet)	8/14/2007	JJF
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